

ECOSPARK®2 320 mJ, 450 V, **N-Channel Ignition IGBT**

FGD3245G2-F085, FGB3245G2-F085

General Description

The FGB3245G2-F085 and FGD3245G2 are N-channel IGBTs designed in onsemi's ECOSPARK-2 technology which helps in eliminating external protection circuitry. The technology is optimized for driving the coil in the harsh environment of automotive ignition systems and offers out-standing Vsat and SCIS Energy capability also at elevated operating temperatures. The logic level gate input is ESD protected and features an integrated gate resistor. An integrated zener-circuitry clamps the IGBT's collecter-to-emitter voltage at 450 V which enables systems requiring a higher spark voltage

Features

- SCIS Energy = 320 mJ at $T_J = 25^{\circ}C$
- Logic Level Gate Drive
- Low Saturation Voltage
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

Applications

- Automotive Ignition Coil Driver Circuits
- Coil On Plug Applications

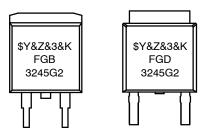


JEDEC TO-263AB D²PAK-3 (TO-263, 3-LEAD) CASE 418AJ



JEDEC TO-263AA DPAK3 (TO-252 3 LD) CASE 369AS

MARKING DIAGRAM



FGB3245G2 = Device Code

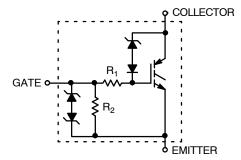
FGD3245G2

1

= onsemi Logo &Z = Assembly Plant Code &3 = 3-Digit Date Code

&K = 2-Digits Lot Run Traceability Code

SYMBOL



ORDERING INFORMATION

See detailed ordering and shipping information on page 7 of this data sheet.

DEVICE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Rating	Unit
BV _{CER}	Collector to Emitter Breakdown Voltage (I _C = 1 mA)	450	V
BV _{ECS}	Emitter to Collector Voltage – Reverse Battery Condition (I _C = 10 mA)	28	V
E _{SCIS25}	Self Clamping Inductive Switching Energy (Note 1)	320	mJ
E _{SCIS150}	Self Clamping Inductive Switching Energy (Note 2)	180	mJ
I _{C25}	Collector Current Continuous, at V _{GE} = 5 V, T _C = 25°C	41	Α
I _{C110}	Collector Current Continuous, at V _{GE} = 5 V, T _C = 110°C	27	Α
V_{GEM}	Gate to Emitter Voltage Continuous	±10	V
P_{D}	Power Dissipation Total, at T _C = 25°C	150	W
	Power Dissipation Derating, for T _C > 25°C	1.1	W/°C
TJ	Operating Junction Temperature Range	-40 to +175	°C
T _{STG}	Storage Junction Temperature Range	-40 to +175	°C
TL	Max. Lead Temp. for Soldering (Leads at 1.6 mm from case for 10 s)	300	°C
T _{PKG}	Max. Lead Temp. for Soldering (Package Body for 10 s)	260	°C
ESD	Electrostatic Discharge Voltage at 100 pF, 1500 Ω	4	kV
	CDM-Electrostatic Discharge Voltage at 1 Ω	2	kV

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality

should not be assumed, damage may occur and reliability may be affected.

1. Self Clamping Inductive Switching Energy (E_{SCIS25}) of 320 mJ is based on the test conditions that starting Tj = 25°C; L = 3 mHy, I_{SCIS} = 14.6 A, V_{CC} = 100 V during inductor charging and V_{CC} = 0 V during the time in clamp.

2. Self Clamping Inductive Switching Energy (E_{SCIS150}) of 180 mJ is based on the test conditions that starting Tj = 150°C; L = 3 mHy, I_{SCIS} = 10.9 A, V_{CC} = 100 V during inductor charging and V_{CC} = 0 V during the time in clamp.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
OFF STATI	E CHARACTERISTICS	•		-	•	-	
BV _{CER}	Collector to Emitter Breakdown Voltage	I_{CE} = 2 mA, V_{GE} = 0, R_{GE} = 1 k Ω , T_{J} = -40 to 150°C		420	_	480	V
BV _{CES}	Collector to Emitter Breakdown Voltage	I_{CE} = 10 mA, V_{GE} = 0 V, R_{GE} = 0, T_{J} = -40 to 150°C		440	-	500	V
BV _{ECS}	Emitter to Collector Breakdown Voltage	$I_{CE} = -75 \text{ mA}, V_{GE} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C}$		28	-	_	V
BV _{GES}	Gate to Emitter Breakdown Voltage	I _{GES} = ±2 mA		±12	±14	-	V
I _{CER}	Collector to Emitter Leakage Current	V_{CE} = 250 V, R_{GE} = 1 k Ω	T _J = 25°C	-	-	25	μΑ
			T _J = 150°C	-	-	1	mA
I _{ECS}	Emitter to Collector Leakage Current	V _{EC} = 24 V	T _J = 25°C	-	-	1	mA
			T _J = 150°C	_	-	40	
R ₁	Series Gate Resistance			_	120	_	Ω
R ₂	Gate to Emitter Resistance			10 k	_	30 k	Ω
ON STATE	CHARACTERISTICS	•		•	•		
V _{CE(SAT)}	Collector to Emitter Saturation Voltage	I _{CE} = 6 A, V _{GE} = 4 V	T _J = 25°C	_	1.13	1.25	V
V _{CE(SAT)}	Collector to Emitter Saturation Voltage	I _{CE} = 10 A, V _{GE} = 4.5 V	T _J = 150°C	_	1.32	1.50	V
V _{CE(SAT)}	Collector to Emitter Saturation Voltage	I _{CE} = 15 A, V _{GE} = 4.5 V	T _J = 150°C	_	1.64	1.85	V
DYNAMIC	CHARACTERISTICS	•					
Q _{G(ON)}	Gate Charge	I _{CE} = 10 A, V _{CE} = 12 V, V	I _{CE} = 10 A, V _{CE} = 12 V, V _{GE} = 5 V		23	-	nC
V _{GE(TH)}	Gate to Emitter Threshold Voltage	I _{CE} = 1 mA, V _{CE} = V _{GE}	T _J = 25°C	1.3	1.6	2.2	V
			T _J = 150°C	0.75	1.1	1.8	
V_{GEP}	Gate to Emitter Plateau Voltage	V _{CE} = 12 V, I _{CE} = 10 A	•	_	2.7	_	V
SWITCHIN	G CHARACTERISTICS						
t _{d(ON)R}	Current Turn-On Delay Time-Resistive	$V_{CE} = 14 \text{ V}, R_L = 1 \text{ k}\Omega$	V_{CE} = 14 V, R_L = 1 k Ω		0.9	4	μs
t _{rR}	Current Rise Time-Resistive	$V_{GE} = 5 \text{ V, R}_{G} = 1 \text{ k}\Omega,$ $T_{.1} = 25^{\circ}\text{C}$		_	2.6	7	μs
t _{d(OFF)L}	Current Turn-Off Delay Time-Inductive	V_{CE} = 300 V, L = 1 mH, V_{GE} = 5 V, R _G = 1 kΩ, I_{CF} = 6.5 A, T _J = 25°C		-	5.4	15	μs
t _{fL}	Current Fall Time-Inductive			_	2.7	15	μs
E _{SCIS}	Self Clamped Inductive Switching	L = 3.0 mHy, RG = 1 kΩ, VGE = 5 V, (Note 3)	TJ = 25°C	-	-	320	mJ
THERMAL	CHARACTERISTICS	•					
$R_{\theta JC}$	Thermal Resistance Junction to Case	All packages		-	_	0.9	°C/W
						L	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product

performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Self Clamping Inductive Switching Energy (E_{SCIS25}) of 320 mJ is based on the test conditions that starting Tj = 25°C; L = 3 mHy, I_{SCIS} = 14.6 A, V_{CC} = 100 V during inductor charging and V_{CC} = 0 V during the time in clamp.

TYPICAL PERFORMANCE CURVES

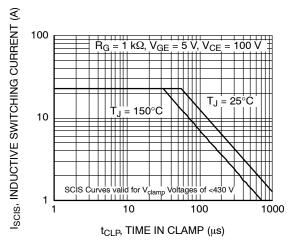


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

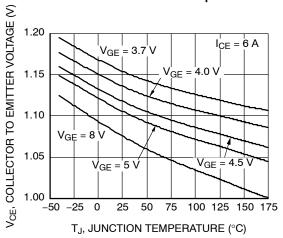


Figure 3. Collector to Emitter On–State Voltage vs. Junction Temperature

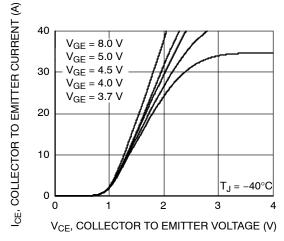


Figure 5. Collector to Emitter On–State Voltage vs. Collector Current

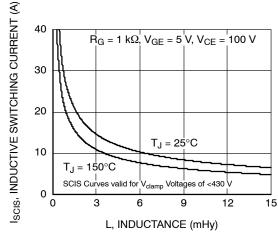


Figure 2. Self Clamped Inductive Switching Current vs. Inductance

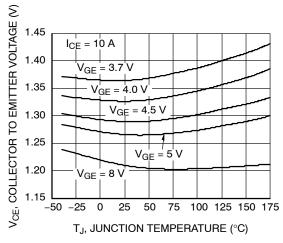


Figure 4. Collector to Emitter On–State Voltage vs. Junction Temperature

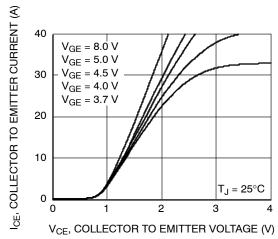


Figure 6. Collector to Emitter On-State Voltage vs. Collector Current

TYPICAL PERFORMANCE CURVES (Continued)

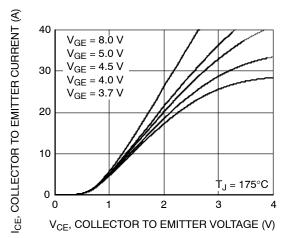


Figure 7. Collector to Emitter On-Stage Voltage vs. Collector Current

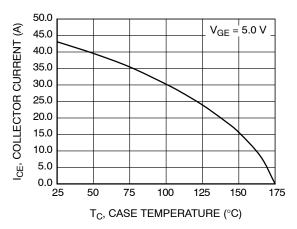


Figure 9. DC Collector Current vs. Case Temperature

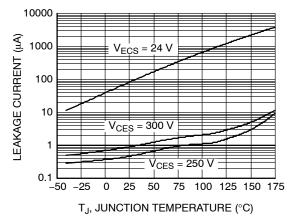


Figure 11. Leakage Current vs. Junction Temperature

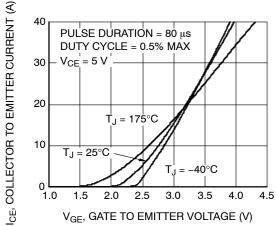


Figure 8. Transfer Characteristics

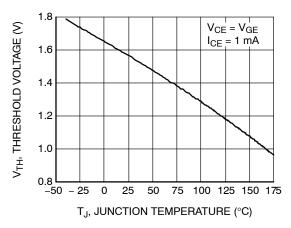


Figure 10. Threshold Voltage vs. Junction Temperature

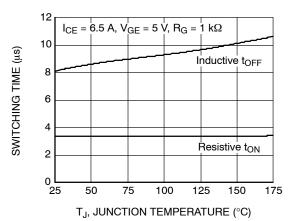


Figure 12. Switching Time vs. Junction Temperature

TYPICAL PERFORMANCE CURVES (Continued)

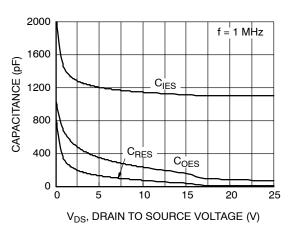


Figure 13. Capacitance Collector to Emitter Voltage

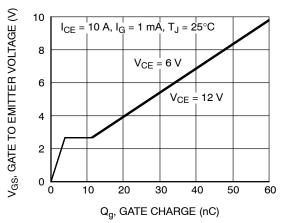


Figure 14. Gate Charge

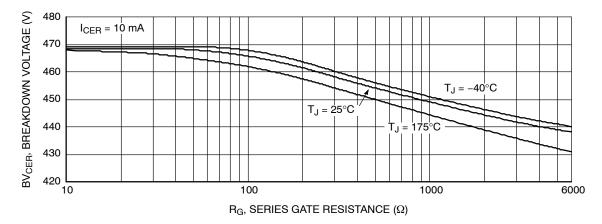


Figure 15. Breakdown Voltage vs. Series Gate Resistance

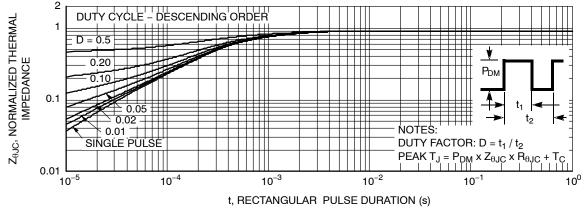
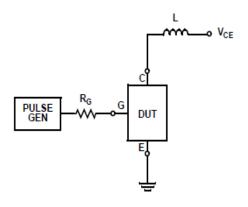


Figure 16. IGBT Normalized Transient Thermal Impedance, Junction to Case

TESTE CIRCUITS AND WAVEFORMS



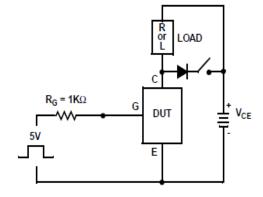
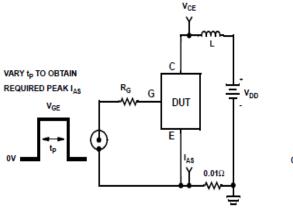


Figure 17. Inductive Switching Test Circuit

Figure 18. t_{ON} and t_{OFF} Switching Test Circuit



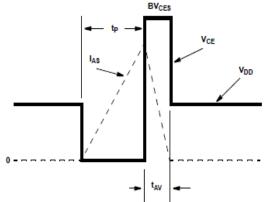


Figure 19. Energy Test Circuit

Figure 20. Energy Waveforms

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Shipping [†]
FGD3245G2	FGD3245G2-F085	DPAK3 (TO-252 3 LD) TO252AA (Pb-Free)	330 mm	16 mm	2500 / Tape & Reel
FGB3245G2	FGB3245G2-F085	D ² PAK-3 (TO-263, 3-LEAD) TO263AB (Pb-Free)	330 mm	24 mm	800 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ECOSPARK is registered trademark of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries.

h3

3

 $-\Box$

L3

Æ

L4

0.25 MAM C





C

(z)

DPAK3 (TO-252 3 LD)CASE 369AS **ISSUE A**

DATE 28 SEP 2022

NOTES: UNLESS OTHERWISE SPECIFIED

- A) THIS PACKAGE CONFORMS TO JEDEC, TO-252,
- ISSUE C, VARIATION AA.
- B) ALL DIMENSIONS ARE IN MILLIMETERS.
- C) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- D) SUPPLIER DEPENDENT MOLD LOCKING HOLES OR CHAMFERED CORNERS OR EDGE PROTRUSION.
- FOR DIODE PRODUCTS, L4 IS 0.25 MM MAX.
- F) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.
- G) LAND PATTERN RECOMMENDATION IS BASED ON IPC7351A STD TO228P991X239-3N.

DIM

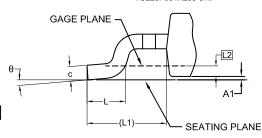
Α

L

11

L2

L3



Α1 0.127 0.00 0.89 b 0.64 0.77 b2 0.76 0.95 1.14 b3 5.21 5.34 5.46 0.61 С 0.45 0.53 c2 0.45 0.52 0.58 D 5.97 6.10 6.22 D1 5.21 Ε 6.35 6.54 6.73 E1 2.286 BSC е e1 4.572 BSC Н 9.40 9.91 10.41

1.40

0.89

1.59

2 90 RFF

0.51 BSC

1.08

1.78

MIN.

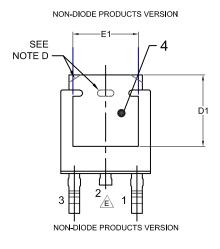
2.18

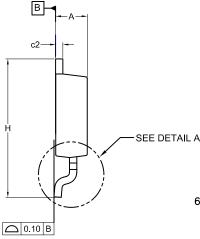
MILLIMETERS

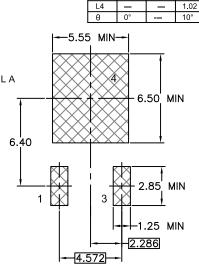
NOM. MAX.

2.39

DETAIL A (ROTATED -90°) SCALE: 12X







GENERIC MARKING DIAGRAM*

XXXXXX XXXXXX **AYWWZZ**

XXXX = Specific Device Code

= Assembly Location Α

WW = Work Week

= Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL COLDEDOM/D

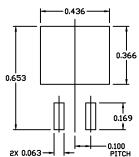
DOCUMENT NUMBER: 98AON13810G		Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	DPAK3 (TO-252 3 LD)		PAGE 1 OF 1		

onsemi and ONSEMI are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.



D²PAK-3 (TO-263, 3-LEAD) CASE 418AJ ISSUE F

DATE 11 MAR 2021



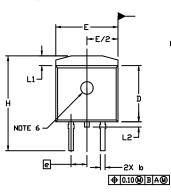
RECOMMENDED MOUNTING FOOTPRINT

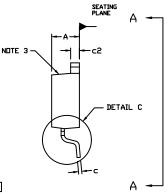
For additional information on our Pb-Free strategy and soldering details, please download the IN Seniconductor Soldering and Mounting Techniques Reference Manual, SILIERRM/D.

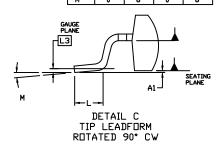
NOTES

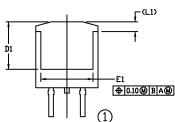
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: INCHES
- 3. CHAMFER OPTIONAL.
- 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH.
 MOLD FLASH SHALL NOT EXCEED 0.005 PER SIDE.
 THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST
 EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 5. THERMAL PAD CONTOUR IS OPTIONAL WITHIN DIMENSIONS E, L1, D1, AND E1.
- 6. OPTIONAL MOLD FEATURE.
- 7. ①,② ... DPTIONAL CONSTRUCTION FEATURE CALL DUTS.

	INCHES		MILLIMETERS			
DIM	MIN.	MAX.	MIN.	MAX.		
Α	0.160	0.190	4.06	4.83		
A1	0.000	0.010	0.00	0.25		
b	0.020	0.039	0.51	0.99		
С	0.012	0.029	0.30	0.74		
c2	0.045	0.065	1.14	1.65		
D	0.330	0.380	8.38	9.65		
D1	0.260		6.60			
E	0.380	0.420	9.65	10.67		
E1	0.245		6.22			
e	0.100	BSC	2.54 BSC			
Н	0.575	0.625	14.60	15.88		
L	0.070	0.110	1.78	2.79		
L1		0.066		1.68		
L5		0.070		1.78		
L3	0.010	BSC	0.25 BSC			
м	0+	8*	n•	8.		

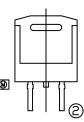


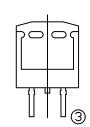


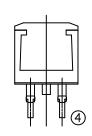




VIEW A-A







VIEW A-A

OPTIONAL CONSTRUCTIONS

GENERIC MARKING DIAGRAMS*

XXXXXX = Specific Device Code A = Assembly Location

 WL
 = Wafer Lot

 Y
 = Year

 WW
 = Work Week

 W
 = Week Code (SSG)

 M
 = Month Code (SSG)

 G
 = Pb-Free Package

 AKA
 = Polarity Indicator

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present. Some products may not follow the Generic Marking.

DOCUMENT NUMBER:

98AON56370E

Electronic versions are uncontrolled except when accessed directly from the Document Repository. Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.

DESCRIPTION:

D²PAK-3 (TO-263, 3-LEAD)

PAGE 1 OF 1

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. ON Semiconductor does not convey any license under its patent rights nor the rights of others.

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative